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Atomic Silicon Quantum Dot Wires and Logic Gates For Binary Computation

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Nanoelectronics has long striven for the ultimate limit of fabrication: reliable use of single atoms as building blocks for computational components. This has required years of development in tools not only to manipulate single atoms with sub-angstrom precision, but also tools that can read the sensitive outputs and dynamics. Here, we report the first example of reversible information transmission through an atomic silicon quantum dot fabricated binary wire and OR gate. We used an atomic force microscope operating in the non-contact regime (NC-AFM) to fabricate, read the output, and actuate both the wire and gate into different readable states. These changes are clearly seen in both raw AFM images, and in kelvin probe force microscopy (KPFM) spectroscopy taken above the silicon quantum dots. This sets the platform for a potential new class of ultra-fast, ultra-power efficient, and ultra dense computing.

INTRODUCTION

The promise of atom scale computing first became a possibility when Eigler et al. controllably moved atoms on a surface to achieve structures of their design [1]. In a subsequent work, the same lab made molecular cascades where, in analogy to falling dominoes, a terminal molecule was tipped to, in turn, tip over a neighboring molecule, which tipped the next molecule, and so on [2]. Separate branches of the cascade were delicately timed to come together in such a way as to achieve binary logic functions. With these results a new era was begun. However, challenges preventing practical applications remained and those limitations have been very difficult to overcome. Some of those challenges are; 1) the need to have the patterned atoms be robust at practical operation temperatures ideally room temperature. The initial atomic patterns were very delicately bound and would not persist above about -280°C [1, 2]. In general, atom fabrication of structures robust enough to withstand relatively high operating temperature are more difficult to make. This is because larger energy inputs from the scanned probe are required to dislodge and move strongly bound atoms, and under such conditions covalent bonds within the probe itself break with some probability comparable to that of the target bond [3]. 2) The patterned atoms need to be electrically distinct from the substrate so as to enable conduction pathways that are not shorted-out or altered by the substrate. Studies performed on metals [4, 5], the most common choice, were therefore limited in that regard. Isolation has been achieved in studies of metal atoms and of molecules separated from a metal substrate by a salt layer, but these have their limitations in uniformity of layer thickness and issues with spontaneous loss of charge to the substrate [6, 7]. 3) The atomic circuitry must not require mechanical or other reset processes (analogous to standing all the dominoes back up) that would prevent the circuitry being instantly reusable.

The above are necessary, but far from sufficient qualities of

a working atomic scale circuitry. Ideally, and to justify the substantial retooling required, a new circuitry should be more than compact. In order to provide a path beyond the established semiconductor roadmap, it must address the particular limitations of todays dominant, and very nearly mature CMOS technology; the primary problem being excessive power density which causes devices to become hot.

By putting aside transistor-based logic that sinks a burst of electrons to ground with every cycle of the clock, to considering field controlled computing schemes such as quantum dot cellular automata [8], it is possible, in principle, to expend only the entropic energy associated with rearranging, but not disposing of electrons. As the load of such circuits present to the clock is essentially reactive, there is the opportunity for very low power and fast resonant clocking also.

These types of low power field controlled binary logic elements formed of quantum dot ensembles have been hypothesized, and even rudimentarily realized, for over a decade now [8–11]. Single electrons, or their absence, serve as 1 and 0 inputs and, likewise, the logic state at the output is represented by a localized charge, the value of which can be read and transmitted by a two-state wire to serve as inputs to subsequent logic elements. Clocking circuitry provides gain by restoring such transmitted signals [8]. It is necessary that electrons exhibit ground state behavior for such quantum dot circuities to operate. If, as typical, the quantum dots are of a size that requires cryogenic conditions to ensure dominant ground state electronic behavior, circuitry built of such dots would also need to operate at cryogenic conditions; a limiting to condition for many applications.

In this work we describe a path forward that addresses these various concerns and is based upon the atomic silicon quantum dot (ASiQD) [12]. ASiQDs, or desorbed single hydrogen atoms from the passivated H-Si(100) surface display quantum dot like behavior in that they can be occupied by 2, 1, or 0 electrons depending on surface doping, surface to bulk potential, and their proximity to each other [13]. These are often

colloquially referred to as dangling bonds (DBs) in the literature, but here we use the term ASiQD to imply a vessel for holding electrons and for forming QD ensembles of higher function, whereas the less specific term dangling bond is used when discussing surface states and their interaction with the bulk at larger applied voltages than involved here.

Using ASiQD, binary atomic silicon logic (BASIL) circuit elements with a bit energy of the order of several 100 meV are demonstrated. This bit energy, somewhat larger than kT, is desirable as information is held just stably enough to withstand environmental noise, while the barrier to purposeful manipulation of data is not so large, as in CMOS today, that excessive energy must be expended to achieve computation inadvertently causing device heating. Prior work also suggests these BASIL circuit elements will work at room temperature, addressing the need for a paradigm not limited by cryo-temperatures [14].

In addition to being small and, therefore, having very large intra-dot energy level spacing, the ASiQDs can be placed very close allowing relatively large interaction energies of order 100 meV [12]. Correspondingly, the tunnel rate between coupled ASiQDs is of order 10 THz for closest spaced dots [14, 15], a large increase over more conventional coupled dots where a rate of GHz is more typical [16]. Tunnel period is a key indicator of information transmission speed along lines of field-coupled bi-stable tunneling oscillators as will be described in the following.

Furthermore, previous work has shown that these ASiQDs can be lithographically patterned with atomic precision using applied voltage pulses with scanning probe microscope tips [17, 18]. Recent work has also shown a powerful capability in lithographic error correction with misplaced ASiQDs erased using "capping" as described in [19], a functionality used to actuate the OR gate as demonstrated later. As the dots contain only one atom, dot size dispersion is zero leading to homogeneity of circuit properties when patterned. And, because the dots are placed on silicon crystalline lattice positions, inhomogeneity related to inter dot spacing is also eliminated.

One further essential characteristic of the atomic circuitry described here must be borne in mind. This relates to the earlier stated need to achieve circuit and substrate isolation. An essential quality of the silicon atom states is that they exist in the silicon substrate band gap. This naturally achieves the substrate-to-atom circuitry electrical isolation required, without the need of a distinct insulating layer. This will prove to be a principal property as it allows isolation, or selective spatial and temporal connection to the bulk at will. As has been shown recently, under these conditions bulk-to-surface state conduction is absent unless a substantial surface to bulk potential is applied [12].

With that in mind, NC-AFM is an optimal tool to look at the charge state switching of these BASIL assemblies. NC-AFM has been proven as a tool capable of resolving differently charged adatoms and molecular species, as well as serving to switch the charge state of said molecules and atoms [7, 20]. Kelvin probe force microscopy specifically has been transfer between the potential wells of tunnel coupled BASIL patterns in a notably minimally-perturbative way, unlike the previous STM analysis of such phenomena. Additionally, we show reversibility by using the "capping", or erasure of ASiQDs to reset outputs of the gate.

RESULTS AND DISCUSSIONS

Earlier experimental and theoretical work established that on highly doped n-type silicon crystals, isolated ASiQDs on the H-Si(100) surface spontaneously accept an additional electron to become occupied by 2 electrons and negatively charged [13, 14, 22–24]. Hence, under the conditions of this study, we expect the ASiQD to be negatively charged at zero bias. However, when sweeping bias, the ASiQD should become neutral upon application of a modest negative sample bias (in the order of \approx -200 mV), and, at higher voltages (usually -1 V or higher) the ASiQD again becomes negative as the depletion barrier separating bulk and surface is overcome allowing the conduction band electrons to fill the ASiQD [17].

The transition of the ASiQD from a negatively charge state at zero bias, to the neutral state at small negative sample bias has been inferred, but never seen because no current is available in the bandgap to generate an STM image or currentvoltage spectrum in that low voltage range. In Figure 1 we show the first experimental evidence of this priorly unseen transition using AFM.

Figure 1-a shows a constant current STM image of an ASiQD created by tip-induced desorption of a single hydrogen atom from the H-Si(100) surface. At relatively high voltages (e.g. -1.7 V), the negatively charged ASiQD appears in filled states images as a bright protrusion surrounded by a characteristic small dark halo [17]. In the corresponding frequency shift map at 0 V (Figure 1-)). hydrogen atoms decorating underneath silicon atoms appear as bright protrusions arranged in the 2×1 surface reconstruction. The ASiQD shows up as a dark feature indicating a much higher tip-sample attractive interaction [19].

Figure 1-c shows I(V) spectroscopy curves taken above the ASiQD and H-Si surface, with both the surface and ASiQD showing a zero current bandgap from around -0.8 to +0.2 V. Figure 1-d shows the Δf (V) spectra, i.e. KPFM spectroscopy, measured above the ASiQD with a bias sweep range of -0.6 to 0 V, a range in the bandgap of the material where no STM information would be available. Interestingly, a sharp step is seen at around -250 mV. Prior work examining charged species [6, 21], electron transfer between molecules [7], and charge state changes in quantum dots [25] in NC-AFM experiments has shown this type of step feature to correspond to a dynamic single-electron charge state change. Therefore, based on previous works, the step seen in Figure 1-d can be



FIG. 1. Probing charge State Transition in an Atomic Silicon Quantum Dot using NC-AFM (a) 3x3 nm filled states STM image (-1.7 V and 50 pA) and (b) corresponding frequency shift map at 0 V of an ASiQD (z_{rel} =-350 p.m and Amp=100 p.m). (c) Current vs. Bias spectroscopy plotted in log scale of the ASiQD (black) and hydrogen terminated surface (red). (d) Frequency shift as a function of voltage measured above the ASiQD.

assigned to the charge state transition of the ASiQD from negative (doubly occupied) to neutral (singly occupied) charge state, respectively right and left of the step in the $\Delta f(V)$ curve around -250 mV.

We will now examine structures constructed from multiple ASiQD. When 2 ASiQDs are closely spaced, within about 1 nm or less, Coulombic repulsion causes one of the pair's extra electrons to delocalize in the conduction band [14, 22]. That loss of an electron creates an unoccupied state in the pair of ASiQDs. That, and the low (0.5 eV) and narrow barrier between the atoms makes tunneling between the paired ASiQDs possible. Figure 2 explores polarization of one of these tunnel coupled pairs of ASiQDs.

Figure 2 (a) and (b) show an STM image of an isolated ASiQD and the corresponding frequency shift map. The Δf (V) spectra (Figure 2 (c)) shows a charge transition step at -0.2 V, We now add on to the ensemble, but with care taken to ensure no tip changes with the addition of ASiQDs, and with identical parameters for AFM and KPFM. In Figure 2 (d) a second ASiQD is created that is tunnel coupled to the first ASiQD from (b). The AFM image in (e) shows 1 intervening hydrogen atom between the pair, with a similar contrast observed above both ASiQDs. The KPFM measurement in (h) corroborates this, showing nearly identical AFM curves taken over the 2 ASiQDs, with the charge transition step shifted to a less negative value occurring now around -0.25 V. We recall that the tunnel coupled pair of ASiQDs, collectively, have a charge of -1, which may account for this horizontal shift.

Finally, a 3rd ASiQD is added in (g), with the AFM image

in (f) showing a 4 H atom separation. This perturbing ASiQD is not significantly tunnel coupled to the pair as the tunneling interaction falls off exponentially, nor Coulombically destabilized enough to lose its negative charge. A stark contrast is now noticed in tunnel coupled pair. The middle ASiQD is significantly lighter than the farthest ASiOD. Delving deeper and looking at the KPFM curves for this "2+1" experiment in Figure 2 (i) (a color coded inset is in the bottom left of (i)), we notice that the KPFM transition energies for the perturbing ASiQD (black) and for the ASiQD furthest left(blue) are markedly more negative than the middle ASiQD (red). The KPFM trace for the middle ASiQD shows a distinctly shifted charge transition energy to +200 mV. This shift is due to the repulsive effect of the perturbing ASiQD. We see that a less negative voltage between probe and sample must be applied to record the negative to neutral charge state transition of this ASiQD. Expressed otherwise, we see that the middle ASiQD at zero probe bias, but under the influence of the negative perturbing ASiQD, is already in the neutral state. It is evident that the tunnel coupled ASiQDs form a double well potential that can be polarized by an electric perturbation. In this example, the double well is tilted to the left causing the shared electron to tend to localize there.

This is our central result for the construction of multiple ASiQD structure such as binary wires. A fixed charge, or a variable bias electrode, can localize charge to one side of a double well potential formed of two tunnel coupled ASiQDs. This allows information to be encoded in spatial charge distributions and, as we will see shortly, for information to be transferred without the use of a conventional current, with minimal energy consumption per operation, and with no quiescent power consumption. We can now expand on this principal.

Figure 3 and 4 show multiple DB pairs aligned end to end, creating atomic binary wires and atomic binary gates. STM images shown in these figures reveal the position of atoms. On the other hand, AFM images in certain height regimes show the position of charges in the structure, and therefore reveal the logical state of the atomic wires or gates. Note that the AFM images were taken at larger tip-sample separations where electrostatic forces are dominant in order to visualize the transmission of information easier. Therefore, they do not resolve the surface structures as seen in Reference [26] and Figure 1 and 2.

Figure 3 shows a STM filled states image of a fabricated 17, 18 and 19 ASiQD atomic binary wires. Colored circles underneath each structure is added for clarity to show the position of negative (blue), neutral (light green) and perturber (red) ASiQDs. Figure 3 shows an atomic binary wire consisting of 8 coupled pairs and a lone un-coupled DB acting as a perturber on the far right. DBs in a pair have a single H atom separation, and pairs are 4 H atoms from each other. Below the STM image in 3 (a) is a constant height AFM image of the ensemble in (b). As before, the far right single perturbing charge breaks the symmetry and induces all pairs to align in one of the two available polarized states (tipping left). Figure 3 (c) shows a STM image of the re-symmetrization of the



FIG. 2. Polarization effect on a multiple Atomic Silicon Quantum dots structure. STM images (-1.8 V and 50 pA), frequency shift maps (z_{rel} =-380 p.m and Amp=100 p.m) and frequency shift versus bias spectra (Δf (V)) for a single ASiQD (a)-(b)-(c), 2 tunnel coupled ASiQDs (d)-(e)-(f) and a 2+1 structure (g)-(h)-(i). The Δf (V) spectra are color-coded according to the arrows in AFM images

wire, with the far right DB now turned into a coupled pair. The wire reacts by dividing down the middle in the frequency shift map of figure 3 (d) with half falling left, and half falling right. The symmetry plain is marked with a dashed white vertical line in the AFM image. Finally, in figure 3 (e) and (f), the same line of pairs is polarized from the opposite side with a 19th DB added on the left. The wire responds by assuming the other remaining polarization state (tipping right), reversing what was shown in figure 3 (a).

Thus, we have demonstrated reversible information transfer expending only the entropic energy associated with rearranging electrons in coupled wells, while also showing, unlike falling dominoes, no reset of the line is needed. The two state line is instantly ready to function again. The scanned probe instrument is not a component of the device, it is only an observer. We do state here that we do not have ready access to a positive charge, but electrons could similarly be pulled instead of pushed if we did.

We show one final adaption of the basic principal established in Figure 2. Figure 4 shows a prototype binary logical OR gate. The two topmost branches are inputs, and the lower branch an output. Figure **??** (a) shows the "central" structure comprising the gate: 3 tunnel coupled pairs arranged at sharp angles and meeting in the center. Isolated from any electrostatic influence, the 2D assembly experiences electrostatic repulsion among the pairs, with electrons localizing to the outside of the branches as indicated by the contrast in the AFM frequency shift map in figure 4 (b).

We note again here the limitation that we can only "push" with the negative charge of a perturbing ASiQD, not "pull". In order to establish an opposite polarization state of the output ASiQD, we make an adaption and fabricate a weak perturber at the terminus of the lower output branch as demonstrated in (d). This perturber acts as a "weak spring", polarizing the bottomost ASiQD from the central structure to be neutral, which we define as the 0 state. This is shown experimentally in (e) and graphically in (f). The first row of the truth table is established with two 0 inputs giving a 0 output.

When a negative input is in place at either the top left (g), top right (j), or both (m) input branches, the weak spring is overcome at the output with electrons in the structure rearranging accordingly and flipping the 0 state of the output to a 1 state as seen in the AFM maps (h), (k), and (n) respectively. Correlating this to the gate output models (i),(l), and (o), this fulfills the rest of the truth table. To complete the truth table, figure 4 (j) was achieved by passivating the ASiQD input on the left in (g) using mechanical passivation, and creating the new input on the right.

CONCLUSION

In this paper we have demonstrated the essential capabilities required to build all-silicon, atom scale electronics for



FIG. 3. Information transmission through atomic silicon quantum dot (ASiQD) constructed binary wire (a) Filled states STM image and (b) corresponding frequency shift maps of a 17 ASiQD wire. Color guides are placed in (b) to show the location of the dots. (c) Symmetric 18 atom ASiQD wire creating from adding on the right of (a). (d) Frequency shift map of the dots showing the symmetry splitting plane marked by the dashed white line (e) 19 atom wire with symmetry broken by adding a ASiQD on the left. (f) Frequency shift map showing the wire polarized to the right. All STM images were taken at V -1.7 and 50pA. All AFM images were taken at 0 V, with a relative tip elevation of z=330 p.m and an oscillation amplitude of 0.5 Å

binary computation. This approach might be dubbed SABL, for silicon atomic binary logic. Though not discussed here, it is evident that analog, and quantum electronics, can be built similarly.

Our primary building block is the atomic silicon quantum dot, first described in 2009 (prl). Crucially, this entity, and the ensembles of multiple dots as described here, exist in the silicon band gap, enabling isolation of this 2 dimensional surface circuitry from the bulk without the need for an additional complicating insulating layer. As shown in recent work (hatem NJP paper and 2 Moe papers,) highly local, indeed atom-scale connection of surface and bulk can be turned on as desired.

Spectra of local force as a function of applied voltage reveal charge state transitions of single dangling bonds and of ensembles. Single electron induced switching of a double dot entity, and of a long sequence of double dots, from Left to Right or binary 0 and 1 states has been shown. A binary OR gate including all states of its truth table have been shown. It is the focus of on-going work to show extension of signals well beyond the gate output as well as NOT and AND functions among others.

Because the gates and the binary wires between gates require only single electron-level electrostatic actuation and because no conventional current is required, power consumption will be extremely low. As the tunnel rate among coupled atomic quantum dots is of the order of femtoseconds (NJP paper on qubits 2010) signal transmission and gating action will be fast. THz operation rates are anticipated. The approach described here may enable a beyond Moore technology combining as it does enormous speed with ultra low power consumption while eliminating transistors.

While we worked on a highly doped n-type substrate here, low doped and p-type doping will enable different charge states and modes of operation. Conventional local doping control will allow mixed modes of operation and more complex function.

These studies were performed at liquid helium temperature because of enhanced instrument stability in that regime. However, previous work shows polarization states as employed here persist at room temperature. Furthermore, the hydrogen terminated silicon system is known to be stable and free of any dangling bond/H atom diffusion to beyond 500K. Parallel work, not shown here, will provide environmental protection through encapsulation and connection of the atomic circuitry to ordinary lithographic features and to CMOS circuitry and is intended to enable operation in a normal packaged chip format. Hybrid SABL CMOS circuitry of lower power consumption and or greater speed is targeted in the near term.

METHODS

Experiments were carried out using a commercial (Omicron) qPlus AFM system operating at 4.5 K. We used highly arsenic-doped ($\sim 1.5 \times 10^{19} atom cm^{-3}$) silicon (100). Sample preparation involved degassing at $\sim 600 \,^{\circ}C$ for about 12 hours in ultra-high-vacuum (UHV), followed by a series of resistive flash anneals reaching 1250°C. Secondary ion mass spectroscopy done in prior works has shown similar heat treatments create a surface regime 60 nm deep where the dopant concentration is reduced near the surface, where the concentration is approximately 40 times less than that of the bulk [17, 27]. Then, while holding the Si substrate at 330°C for 2 minutes, molecular hydrogen at 10^6 Torr was cracked on a 1600°C tungsten filament held approximately 10 cm from the sample to create the 2×1 reconstructed hydrogen atom-terminated Si(100) surface.

We used qPlus AFM sensors [28] with a separate electrode for tunnel current. Focused ion beam (FIB) was used to cut a micro-tip from an electrochemically etched 50 μ m polycrystalline tungsten wire, then weld it to the sensor. This fabrication technique ensured high sensitivity and well defined sensor mechanical properties [29].

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FIG. 4. **Prototype of a functional OR gate constructed using atomic silicon quantum dots (ASiQD).** The first row shows constant current filled states STM images (-1.8V, 50pA) of the OR gate, and the second row the corresponding frequency shift maps (0V, Z 3.5 Å). The 3rd row includes the truth table of an OR gate (c), along with models for the switching inputs and outputs corresponding to the gate states displayed in rows one and two.

After being loaded in UHV, tips first had the oxide layer removed by several electron beam heating treatments followed by field evaporation cleaning of the apex in a field ion microscope (FIM). Further sharpening was conducted using a FIM nitrogen etching process to obtain the smallest possible tip radius of curvature [29, 30]. Final in-situ tip processing was done through creation of a bare silicon patch through tip induced hydrogen desorption, followed by gentle controlled contacts with the tip on the reactive patch. This procedure usually results in a stable and artifact free tip [26].

To create an ASiQD, the tip is positioned on top of a surface hydrogen atom at 1.3 V and 50 pA, and applying pulses of 2.5 V for 10 ms. Mechanically induced covalent bonding of a single H atom at the tip apex and the silicon ASiQD to passivate it was done by following the procedure described in details in [19].

Nanonis control electronics and software were used for both STM and AFM data acquisition. For all frequency shift maps, Z=0 Å corresponds to the relative tip elevation defined by the STM imaging set points 50 pA and -1.8 V. To minimize drift during AFM image acquisition, the tip was left to settle for about 12 hours after approach to allow piezo scanner stabilization. Additionally, an atom tracking program was used. All STM images are raw data.

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